

Global United Technology Services Co., Ltd.

Report No.: GTS201705000186E03

SPECTRUM REPORT

Applicant: Dragino Technology Co., Limited

Room 1101. City Invest Commercial Center. No.546 **Address of Applicant:**

QingLinRoad, LongCheng Street, LongGang District, Shenzhen

518116, China

Dragino Technology Co., Limited **Manufacturer/ Factory:**

Address of Room 1101, City Invest Commercial Center, No.546

QingLinRoad, LongCheng Street, LongGang District, Shenzhen Manufacturer/ Factory:

518116, China

Equipment Under Test (EUT)

LoRa IoT Gateway **Product Name:**

LG01, LG01-P, LG01-S, MS14N-P, MS14N-S Model No.:

ETSI EN 300 220-1 V3.1.1 (2017-02), **Applicable standards:**

ETSI EN 300 220-2 V3.1.1 (2017-02)

June 15, 2017 Date of sample receipt:

Date of Test: June 15-20, 2017

Date of report issue: June 20, 2017

PASS * Test Result:

*In the configuration tested, the EUT complied with the standards specified above.

The CE mark as shown below can be used, under the responsibility of the manufacturer, after completion of an EC Declaration of Conformity and compliance with all relevant EC Directives. The protection requirements with respect to electromagnetic compatibility contained in Directive 2014/53/EU are considered.



Robinson Lo **Laboratory Manager**



2 Version

Version No.	Date	Description
00	June 20, 2017	Original

Prepared By:	Joseph Cu	Date:	June 20, 2017	
Check By:	Project Engineer Andy w	Date:	June 20, 2017	
	Reviewer			



3 Contents

			Page
1	COVER	R PAGE	1
2	VERSIO	ON	2
3	CONTE	ENTS	2
၁	CONTE	EN13	3
4	TEST S	SUMMARY	4
5	GENER	RAL INFORMATION	5
	5.1 G	ENERAL DESCRIPTION OF EUT	5
		EST MODE	
		EST FACILITY	
		EST LOCATION	
		ESCRIPTION OF SUPPORT UNITS	
		EVIATION FROM STANDARDS	
		BNORMALITIES FROM STANDARD CONDITIONS	
	5.8 O	THER INFORMATION REQUESTED BY THE CUSTOMER	6
6	TEST II	NSTRUMENTS LIST	7
7	BADIO	TECHNICAL REQUIREMENTS SPECIFICATION IN ETSI EN 300 220-2	۰
′			
	7.1.1	Test conditions	
	7.1.2	Operation Frequency	
	7.1.3 7.1.4	Effective Radiated Power	
	7.1. 4 7.1.5	Duty Cycle Occupied Bandwidth	
	7.1.5 7.1.6	Frequency Error	
	7.1.0 7.1.7	TX Out Of Band Emissions	
	7.1.8	Transient power	
	7.1.9	Adjacent Channel Power	
	7.1.10	Adaptive Power Control	
	7.1.10	Transmit spurious emissions	
	7.1.12	TX Behaviour under Low-voltage Conditions	
8		SETUP PHOTO	
۵		ONSTRUCTIONAL DETAILS	27



4 Test Summary

Ra	dio Spectrum Matter	(RSM) Part of Tx		
Test item	Test Requirement	Test method	Limit/Severity	Result
Operating frequency(Declared by manufacturer)	ETSI EN 300 220-2	ETSI EN 300 220-1	Annexes B or C of EN 300 220-2	Pass
Effective Radiated Power	ETSI EN 300 220-2	ETSI EN 300 220-1	Annexes B or C of EN 300 220-2	Pass
Maximum e.r.p. Spectral Density	ETSI EN 300 220-2	ETSI EN 300 220-1	Annexes B or C of EN 300 220-2	N/A
Duty cycle	ETSI EN 300 220-2	ETSI EN 300 220-1	Annexes B or C of EN 300 220-2	Pass
Occupied Bandwidth	ETSI EN 300 220-2	ETSI EN 300 220-1	Annexes B or C of EN 300 220-2	Pass
Tx Out of Band Emissions	ETSI EN 300 220-2	ETSI EN 300 220-1	Clause 5.8.2	Pass
Transmit Spurious Emmisions	ETSI EN 300 220-2	ETSI EN 300 220-1	Clause 5.9.2	Pass
Transmit Spectrum Mask	ETSI EN 300 220-2	ETSI EN 300 220-1	Clause 5.9.1.1	N/A
Transient Power	ETSI EN 300 220-2	ETSI EN 300 220-1	Clause 5.10.2	Pass
Adjacent Channel Power	ETSI EN 300 220-2	ETSI EN 300 220-1	Clause 5.11.2	N/A
TX behaviour under Low Voltage Conditions	ETSI EN 300 220-2	ETSI EN 300 220-1	Clause 5.12.2	Pass
Adaptive Power Control	ETSI EN 300 220-2	ETSI EN 300 220-1	Clause 5.13.2	N/A
Short Term Behaviour	ETSI EN 300 220-2	N/A	annex C, table C.1	N/A
FHSS Equipment Requirements	ETSI EN 300 220-2	N/A	Clause 4.3.10.2	N/A
Ra	dio Spectrum Matter	(RSM) Part of Rx		
Test item	Test Requirement	Test method	Limit/Severity	Result
Receiver sensitivity	ETSI EN 300 220-2	ETSI EN 300 220-1	Clause 5.14.2	N/A
Adjacent channel selectivity	ETSI EN 300 220-1	ETSI EN 300 220-1	Clause 5.15.2	N/A
Receiver saturation at Adjacent Channel	ETSI EN 300 220-1	ETSI EN 300 220-1	Clause 5.16.2	N/A
Spurious response rejection	ETSI EN 300 220-1	ETSI EN 300 220-1	Clause 5.17.2	N/A
Blocking	ETSI EN 300 220-2	ETSI EN 300 220-1	Clause 5.18.2	N/A
Behaviour at high wanted signal level	ETSI EN 300 220-1	ETSI EN 300 220-1	Clause 5.19.2	N/A
Clear Channel Assessment threshold	ETSI EN 300 220-2	ETSI EN 300 220-1	Clause 5.21.2.2	N/A
Polite spectrum access timing parameters	ETSI EN 300 220-2	ETSI EN 300 220-1	Clause 5.21.3.1	N/A
Adaptive Frequency Agility	ETSI EN 300 220-2 N/A N/A		N/A	
Receive Spurious emmisions	ETSI EN 300 220-2	ETSI EN 300 220-1	Clause 5.9.2	N/A
Bi-Directional Operation Verification	ETSI EN 300 220-1	ETSI EN 300 220-1	Clause 5.22.2	N/A

Pass: The EUT complies with the essential requirements in the standard.

N/A: not applicable.

Global United Technology Services Co., Ltd.

No. 301-309, 3/F., Jinyuan Business Building, No.2, Laodong Industrial Zone,

Xixiang Road, Baoan District, Shenzhen, Guangdong, China 518102



5 General Information

5.1 General Description of EUT

Product Name:	LoRa loT Gateway		
Model No.:	LG01, LG01-P, LG01-S, MS14N-P, MS14N-S		
Test Model No.:	LG01		
Remark: All above models are identifications difference is the model name	ical in the same PCB layout, interior structure and electrical circuits. The only of for commercial purpose.		
Operation Frequency:	868.1MHz(Declared by manufacturer)		
Occupied bandwidth	200kHz(Declared by manufacturer)		
Antenna type:	Integrated antenna		
Antenna Gain:	2.5dBi(Declared by manufacturer)		
Modulation type:	FSK(Declared by manufacturer)		
	Adapter		
Power supply:	Input: AC100-240V 50-60Hz 0.5A		
	Output: DC12V 0.1-1.3A		

5.2 Test mode

T	Lizaca da Elizaca de la casa de Casa d
Transmitting mode	Keep the EUT in continuously transmitting mode
rranomiting mode	, recop the Eor in continuously transmitting meas



5.3 Test Facility

The test facility is recognized, certified, or accredited by the following organizations:

• FCC —Registration No.: 600491

Global United Technology Services Co., Ltd., Shenzhen EMC Laboratory has been registered and fuly described in a report filed with the (FCC) Federal Communications Commission. The acceptance letter from the FCC is maintained in files. Registration 600491, June 22, 2016.

• Industry Canada (IC) —Registration No.: 9079A-2

The 3m Semi-anechoic chamber of Global United Technology Services Co., Ltd. has been registered by Certification and Engineering Bureau of Industry Canada for radio equipment testing with Registration No.: 9079A-2, August 15, 2016.

5.4 Test Location

All tests were performed at:

Global United Technology Services Co., Ltd.

Address: No. 301-309, 3/F., Jinyuan Business Building, No.2, Laodong Industrial Zone, Xixiang Road,

Baoan District, Shenzhen, Guangdong, China 518102

Tel: 0755-27798480 Fax: 0755-27798960

5.5 Description of Support Units

None

5.6 Deviation from Standards

None

5.7 Abnormalities from Standard Conditions

None

5.8 Other Information Requested by the Customer

None



6 Test Instruments list

Rad	Radiated Emission:					
Item	Test Equipment	Manufacturer	Model No.	Inventory No.	Cal.Date (mm-dd-yy)	Cal.Due date (mm-dd-yy)
1	3m Semi- Anechoic Chamber	ZhongYu Electron	9.2(L)*6.2(W)* 6.4(H)	GTS250	July 03 2015	July 02 2020
2	Control Room	ZhongYu Electron	6.2(L)*2.5(W)* 2.4(H)	GTS251	N/A	N/A
3	Spectrum Analyzer	Agilent	E4440A	GTS533	June 29 2016	June 28 2017
4	EMI Test Receiver	Rohde & Schwarz	ESU26	GTS203	June 29 2016	June 28 2017
5	BiConiLog Antenna	SCHWARZBECK MESS-ELEKTRONIK	VULB9163	GTS214	June 29 2016	June 28 2017
6	Double -ridged waveguide horn	SCHWARZBECK MESS-ELEKTRONIK	9120D-829	GTS208	June 29 2016	June 28 2017
7	Horn Antenna	ETS-LINDGREN	3160	GTS217	June 29 2016	June 28 2017
8	EMI Test Software	AUDIX	E3	N/A	N/A	N/A
9	Coaxial Cable	GTS	N/A	GTS213	June 29 2016	June 28 2017
10	Coaxial Cable	GTS	N/A	GTS211	June 29 2016	June 28 2017
11	Coaxial cable	GTS	N/A	GTS210	June 29 2016	June 28 2017
12	Coaxial Cable	GTS	N/A	GTS212	June 29 2016	June 28 2017
13	Amplifier(100kHz-3GHz)	HP	8347A	GTS204	June 29 2016	June 28 2017
14	Amplifier(2GHz-20GHz)	HP	8349B	GTS206	June 29 2016	June 28 2017
15	Amplifier (18-26GHz)	Rohde & Schwarz	AFS33-18002 650-30-8P-44	GTS218	June 29 2016	June 28 2017
16	Band filter	Amindeon	82346	GTS219	June 29 2016	June 28 2017
17	Power Meter	Anritsu	ML2495A	GTS540	June 29 2016	June 28 2017
18	Power Sensor	Anritsu	MA2411B	GTS541	June 29 2016	June 28 2017



7 Radio Technical Requirements Specification in ETSI EN 300 220-2

7.1.1 Test conditions

	Ambient:	Temperature.:	+15°C to +35°C
Normal conditions		relative humidity:	20 % to 75 %
Normal Conditions	Dower oupply	Battery:	Nominal
	Power supply:	AC mains source	Nominal
	Ambient:	Temperature.:	-20°C to +55°C
Extreme conditions	Power supply:	Battery:	0.9 and 1.3 mutiplied for lead-acid battery 0.85 and 1.15 mutiplied for gel-cell type batteries 0.85 and 0.9 mutiplied for lithium and nickel- cadmium type batteries For other types it may declared by manufacturer
		AC mains source	\pm 10% of the norminal power source

7.1.2 Operation Frequency

The Operational Frequency band was declared by the manufacturer which conforms annexes B, C or any NRI of ETSI EN 300220-2.



7.1.3 Effective Radiated Power

	1.3 Effective Radiated Power		
Test Requirement:	ETSI EN 300 220-2 clause 4.3.1		
Test Method:	ETSI EN 300 220-1 clause 5.2.2		
Test site:	Measurement Distance: 3m (Semi-Anechoic Chamber)		
Receiver setup:	RBW=120kHz, VBW=300kHz, Detector= peak		
Limit:	10mW=10dBm (Refer to Annex B of ETSI EN 300220-2)		
Test setup:	Antenna Tower 1.50m (Turntable) Ground Reference Plane Tost Receiver Archice Controlles		
Test procedure:	Substitution method was performed to determine the actual ERP emission levels of the EUT. The following test procedure as below: 1. On the test site as test setup graph above, the EUT shall be placed at the 1.5m support on the turntable and in the position closest to normal use as declared by the provider. 2. The test antenna shall be oriented initially for vertical polarization and shall be chosen to correspond to the frequency of the transmitter. The output of the test antenna shall be connected to the measuring receiver. 3. The transmitter shall be switched on, if possible, without modulation and the measuring receiver shall be tuned to the frequency of the transmitter under test. 4. The test antenna shall be raised and lowered from 1m to 4m until a maximum signal level is detected by the measuring receiver. Then the turntable should be rotated through 360° in the horizontal plane, until the maximum signal level is detected by the measuring receiver. 5. Repeat step 4 for test frequency with the test antenna polarized horizontally. 6. Remove the transmitter and replace it with a substitution antenna (the antenna should be half-wavelength for each frequency involved). The center of the substitution antenna should be approximately at the same location as the center of the transmitter. At the lower frequencies, where the substitution antenna is very long, this will be impossible to achieve when the antenna is polarized vertically. In such case the lower		
	7. Feed the substitution antenna at the transmitter end with a signal generator connected to the antenna by means of a nonradiating cable.		



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	With the antennas at both ends vertically polarized, and with the signal generator tuned to a particular test frequency, raise and lower the test antenna to obtain a maximum reading at the spectrum analyzer. Adjust the level of the signal generator output until the previously recorded maximum reading for this set of conditions is obtained. This should be done carefully repeating the adjustment of the test antenna and generator output.
	Repeat step 7 with both antennas horizontally polarized for each test frequency.
	9. Calculate power in dBm into a reference ideal half-wave dipole antenna by reducing the readings obtained in steps 7 and 8 by the power loss in the cable between the generator and the antenna, and further corrected for the gain of the substitution antenna used relative to an ideal half-wave dipole antenna by the following formula:
	ERP(dBm) = Pg(dBm)) + antenna gain (dBd)
	where:
	Pg is the generator output power into the substitution antenna.
Measurement Record:	Uncertainty: ± 1.5dB
Test Instruments:	Refer to section 6.0 for details
Test mode:	Refer to section 5.2 for details
Test results:	Pass

Measurement Data

Test mode	Frequency (MHz)	ERP Level (dBm)	Limit (dBm)	Result
Transmitting with modulation	868.1	11.82	13.9794	Pass

Remark:Peak value is applicable.

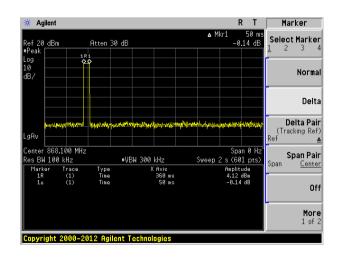


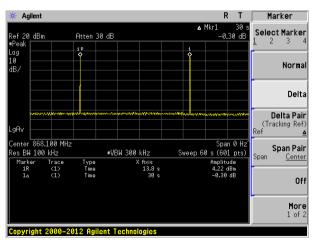
7.1.4 Duty Cycle

Test Requirement:	ETSI EN 300 220-2 clause 4.3.3	
Test Method:	ETSI EN 300 220-1 clause 5.4	
Limit:	1%	
Test setup:	Spectrum Analyzer E.U.T Non-Conducted Table Ground Reference Plane	
Test Instruments:	Refer to section 6.0 for details	
Test mode:	Refer to section 5.2 for details	
Test results:	Pass	

Measurement Data

Ton time(ms)	Tcycle time(s)	Dutycycle	Limit	Result
50	30	0.17%	1%	Pass







7.1.5 Occupied Bandwidth

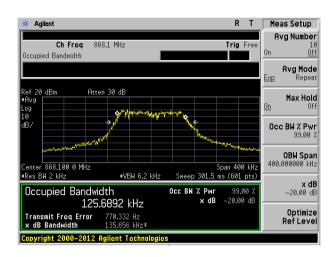
Test Requirement:	ETSI EN 300 220-2 clause 4.3.4		
Test Method:	ETSI EN 300 220-1 clause 5.6		
Receive setup:	Table 12: Test Parameters for Max Occupied Bandwidth Measurement		
	Setting	Value	Notes
	Centre frequency	The nominal Operating	The highest or lowest Operating Frequency as declared by
	RBW	Frequency 1 % to 3 % of OCW without being below	the manufacturer
	VBW	100 Hz 3 x RBW	Nearest available analyser setting to 3 x RBW
		At least 2 x Operating	Span should be large enough to include all major
	Span	Channel width	components of the signal and its side bands
	Detector Mode Trace	RMS May hold	
	Trace	Max hold	
Limit:	The Operating Channel shall be declared and shall reside entire Operational Frequency Band. The Maximum Occupied Bandwidth at 99 % shall reside entire Operating Channel defined by Flow and Fhigh. Note: For 865 MHz to 868 MHz FHSS equipment. The Maximum bandwidth per hopping channel shell less or equal to 50kHz. For to 870 MHz FHSS equipment. The Maximum occupied bandwidth hopping channel shell less or equal to 100kHz.		
Test setup:	Enact	rum Analyzer	
		Non-Conducte Ground Referen	
Test Procedure:	Step 1:		
Tool Foodule.	Operation of the as declared by The signal atternoise signals of measurement. Step 2: When the trace and the analyses Step 3: The 99 % occurrence of the analyses of the step 10 occurrence occurrence of the step 10 occurrence occu	the manufacturer enuation shall be a fficiently above the on either side of the e is completed the er marker placed upied bandwidth fu	arted, on the highest operating frequency, with the appropriate test signal. djusted to ensure that the signal power enoise floor of the analyser to avoid the e power envelope being included in the peak value of the trace shall be located on this peak. Inction of the spectrum analyser shall be andwidth of the signal.
Measurement Record:			Uncertainty: ±5%
Test Instruments:	Refer to section	n 6.0 for details	
Test mode:	Refer to section	n 5.2 for details	



Measurement Data

99% Occupied Bandwidth(KHz)	Limit	Result
125.6892	Within the band refer to Anex B or C	Pass

Plot:





7.1.6 Frequency Error

Test Requirement:	ETSI EN 300 220-2 clause 4.3.3	
Test Method:	ETSI EN 300 220-1 clause 5.7	
Test setup:	Spectrum Analyzer E.U.T Non-Conducted Table Ground Reference Plane	
Test Procedure:	Step 1: Operation of the EUT shall be started on the nominal frequency as declared by the manufacturer under extreme high temperature and extreme voltage conditions. The frequency of the unmodulated carrier shall be measured and noted. Step 2: Operation of the EUT shall be started on the nominal frequency as declared by the manufacturer under extreme low temperature and extreme voltage conditions.	
Measurement Record:	Uncertainty: ± 0.5ppm	
Test Instruments:	Refer to section 6.0 for details	
Test mode:	Refer to section 5.2 for details	
Test results:	Pass	

Measurement Data

Test conditions	Frequency(MHz)	A-N(KHz)	B-N(KHz)
N(NTNV)	868.1		
B(HTHV)	868.1	0.000	0.000
A(LTLV)	868.1		

Remark:HTHV is the extreme high temperature and extreme voltage condition. LTLV is the extreme low temperature and extreme voltage condition.

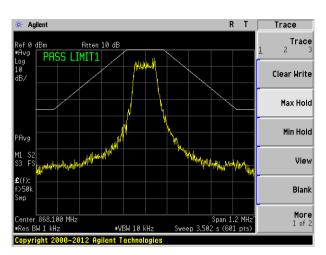


7.1.7 TX Out Of Band Emissions

Test Requirement:	ETSI EN 300 220	-2 clause 4.3.5				
Test Method:	ETSI EN 300 220-1 clause 5.8.3					
Receive setup:	Table 16: Test	Table 16: Test Parameters for Out Of Band for Operating Channel Measurement				
	Spectrum Analy Setting	yser Value	Notes			
	Centre frequency	Operating				
	Span	Frequency 6 x Operating				
	RBW	Channel width 1 kHz	Resolution ban	ndwidth for Out C	Of Band domain	
	Detector Function	(see note) RMS	measurements	;		
	Trace Mode	Linear AVG	An appropriate averaged to give	number of sam ve a stable read	ing	
		Max Hold	Applies only fo test signal.	r EUT generatin	g D-M2a or D-M3	
	NOTE: If the value	e of RBW used is different f		clause 5.8.2, use	the bandwidth	
	correction	in clause 4.3.10.1.				
		Table 15: Emission limits	in the Out Of Ba	nd domains		
	Domain	Frequency Rar		RBW _{REF}	Max power lim	
		f ≤ f _{low_OFB} - 400	kHz	10 kHz 1 kHz	-36 dBm	
		F _{low_OFB} - 400 KHZ ≤ I ≤ I _{low}	OFB - 400 kHz ≤ f ≤ f_{low_OFB} - 200 kHz flow - 200 kHz ≤ f < f_{low_OFB}		-36 dBm See Figure 6	
	OOB limits applicable to Operational Frequency		f = f _{low_OFB}		0 dBm	
	Band	f = f _{high_OFB}		1 kHz 1 kHz	0 dBm	
	(See Figure 6)	F _{high_OFB} < f ≤ f _{high_OFB}	$F_{high_OFB} < f \le f_{high_OFB} + 200 \text{ kHz}$		See Figure 6	
		F _{high OFB} + 200 kHz ≤ f ≤ f _{hig}	h OFB + 400 kHz	1 kHz	-36 dBm	
Limit:			F _{high_OFB} + 400 kHz ≤ f		-36 dBm	
LIIIIII.			$f = f_c - 2.5 \text{ x OCW}$ $f_c - 2.5 \text{ x OCW} \le f \le f_c - 0.5 \text{ x OCW}$		-36 dBm	
	OOB limits applicable to			1 kHz	See Figure 5	
	Operating Channel	$f = f_c - 0.5 \times 0.00$ $f = f_c + 0.5 \times 0.00$		1 kHz 1 kHz	0 dBm 0 dBm	
	(See Figure 5)	$f_c + 0.5 \times OCW \le f \le f_c +$		1 kHz	See Figure 5	
		f = f _c + 2,5 x OC		1 kHz	-36 dBm	
	NOTE: f is the measurement frequency. f _c is the Operating Frequency. F _{low_OFB} is the lower edge of the Operational Frequency Band. F _{high_OFB} is the upper edge of the Operational Frequency Band. OCW is the operating channel bandwidth.					
Test setup:	Spectrum Analyzer E.U.T Non-Conducted Table					
		Ground Reference Pla	ane			
Test Procedure:	Refer to clause 5.	8.3.4 of ETSI EN30	00220-1			
Test Instruments:	Refer to section 6	i.0 for details				
Test mode:	Refer to section 5	.2 for details				
Test results:	Pass					



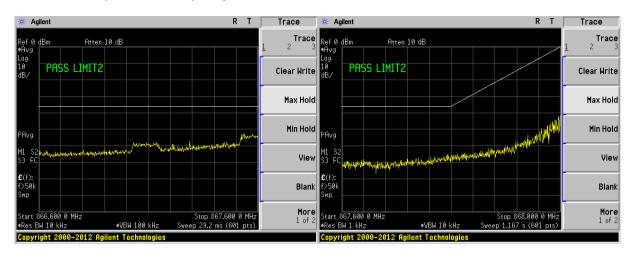
Measurement Data

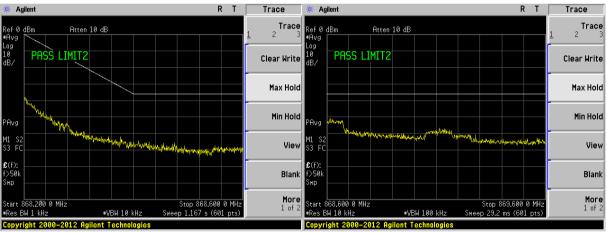


OOB Data of Operational Channel



OOB Data of Operational Frequency Band







7.1.8 Transient power

Test Requirement:	ETSI EN 300 220-2 Clause 4.3.6				
Test Method:	ETSI EN 300 220-1 Clause 5.10.3				
Limit:	Table 23: Transmitter Transient Power limits			er limits	
	Absolute offset from centre frequency	RBW _{REF}	Peak power limit applicable at measurement p		ement points
	≤ 400 kHz > 400 kHz	1 kHz 1 kHz		0 dBm -27 dBm	
	The output of the EUT sh	-	ootod to o on		r or oquivalent
Test procedure:	measuring equipment. The measurement shall to centre frequency shall be These offset values and Table 24.	an mode. The a	analyser's re frequency.		
	Measurement points:		Analyser RE	sw	RBW _{REF}
	-0.5 x OCW - 3 kHz		1 kHz		KEF
	0,5 x OCW + 3 kHz Not applicable for OCW < 25 kHz				1kHz
	±12,5 kHz or ±0CW whichever is the greater	Max (RI	BW pattern 1, 3, 1 frequency/6 (see		1 kHz
	-0,5 x OCW - 400 kHz 0,5 x OCW + 400 kHz		100 kHz		1 kHz
	-0,5 x OCW -1 200 kHz 0,5 x OCW + 1 200 kHz			1 kHz	
	3 kHz. The rest	settings are listed	ding to one OCW offs I in Table 25, and if O offset frequency is 30	CW is 250 kHz	
	Table	25: Parameter	s for Transient I		KHZ.
		25: Parameter		Measurement Not	es
	Table	25: Parameter Va	s for Transient I	Measurement	es s VBW may be
	Spectrum Analyser Setting VBW/RBW Sweep time	25: Parameter Va 1 500	s for Transient I lue 0 ms	Measurement Not At higher RBW values	es s VBW may be
	Table Spectrum Analyser Setting VBW/RBW Sweep time RBW filter	25: Parameter Va 1 500 Gau:	s for Transient I lue 0 ms ssian	Measurement Not At higher RBW values	es s VBW may be
	Table Spectrum Analyser Setting VBW/RBW Sweep time RBW filter Trace Detector Function	25: Parameter Va 1 500 Gau: RI	s for Transient I lue 0 ms ssian MS	Measurement Not At higher RBW values	es s VBW may be
	Table Spectrum Analyser Setting VBW/RBW Sweep time RBW filter	25: Parameter Va 1 500 Gau: Ri Max	s for Transient I lue 0 ms ssian	Measurement Not At higher RBW values	es s VBW may be
	Spectrum Analyser Setting VBW/RBW Sweep time RBW filter Trace Detector Function Trace Mode	25: Parameter Va 1 500 Gau: R! Max 500 Continuo	s for Transient I lue 0 ms ssian MS hold D1 us sweep	Measurement Not At higher RBW values clipped to its maximul	es s VBW may be m value
	Spectrum Analyser Setting VBW/RBW Sweep time RBW filter Trace Detector Function Trace Mode Sweep points Measurement mode NOTE: The ratio between the nu	25: Parameter Va 1 500 Gau: RI Max Continuo mber of sweep p p points is used. all be D-M3. ment shall be st five D-M3 rement shall es shall be	s for Transient I	Not At higher RBW values clipped to its maximum ep time shall be the sar ar shall be set to each offset free The peak value d at each offset	es s VBW may be m value me ratio as above if the settings of quency. The shall be frequency
Measurement Record:	Spectrum Analyser Setting VBW/RBW Sweep time RBW filter Trace Detector Function Trace Mode Sweep points Measurement mode NOTE: The ratio between the nudifferent number of sweet The used modulation shated Table 25 and a measurer EUT shall transmit at least recorded and the measurementioned in Table 24. The recorded power value	25: Parameter Va 1 500 Gau: RI Max Continuo mber of sweep p p points is used. all be D-M3. ment shall be st five D-M3 rement shall es shall be	s for Transient I	Not At higher RBW values clipped to its maximul ep time shall be the sar er shall be set to each offset free The peak value d at each offset i	es s VBW may be m value me ratio as above if the settings of quency. The shall be frequency
Measurement Record: Test Instruments:	Spectrum Analyser Setting VBW/RBW Sweep time RBW filter Trace Detector Function Trace Mode Sweep points Measurement mode NOTE: The ratio between the nudifferent number of sweet The used modulation shated Table 25 and a measurer EUT shall transmit at least recorded and the measurementioned in Table 24. The recorded power value	25: Parameter Va 1 500 Gau: RI Max Continuo mber of sweep p p points is used. all be D-M3. ment shall the st five D-M3 rement shall es shall be in clause 4	s for Transient I	Not At higher RBW values clipped to its maximul ep time shall be the sar er shall be set to each offset free The peak value d at each offset i	es s VBW may be m value me ratio as above if the settings of quency. The shall be frequency neasured in
	Spectrum Analyser Setting VBW/RBW Sweep time RBW filter Trace Detector Function Trace Mode Sweep points Measurement mode NOTE: The ratio between the nudifferent number of sweet The used modulation shate Table 25 and a measurer EUT shall transmit at least recorded and the measure mentioned in Table 24. The recorded power value RBWREF by the formula	Va 1 500 Gaue Ri Max 500 Continuo mber of sweep p p points is used. All be D-M3. ment shall be st five D-M3 rement shall es shall be in clause 4	s for Transient I	Not At higher RBW values clipped to its maximul ep time shall be the sar er shall be set to each offset free The peak value d at each offset i	es s VBW may be m value me ratio as above if the settings of quency. The shall be frequency neasured in



Measurement Data

Frequency offset	Peak Power level (dBm)	Limit (dBm)	Result	
< 400 kH=	-18.22	0.00		
≤ 400 kHz	-17.26	0.00	Daga	
. 400 kH=	-31.25	-27.00	Pass	
> 400 kHz	-30.25	-27.00		



7.1.9 Adjacent Channel Power

Test Requirement:	ETSI EN 300 220-2 Clause 4.3.7				
Test Method: ETSI EN 300 220-1 Clause 5.11.3					
Limit: Tabl		Table 26: Adjacent channel power limits for transmitters with OCW ≤ 25 kHz			
			Adjacent Channel power integrated over 0,7 x OCW	Alternate Adjacent Channel power integrated over 0,7 x OCW	
	OCW < 20 kHz Normal test conditions -20 dBm		-20 dBm		
	OCW \ 20 KHZ	Extreme test conditions	-15 dBm	-20 dBm	
	OCW ≥ 20 kHz	Normal test conditions	-37 dBm	-40 dBm	
	OCVV 2 20 KHZ	Extreme test conditions	-32 dBm	-37 dBm	
		-			

Test procedure:

The spectrum analyser shall be configured as appropriate for the parameters shown in Table 27.

Table 27: Test Parameters for Adjacent Channel Power

Setting	Value	Notes		
Centre frequency	The nominal Operating			
Certifie frequency	Frequency			
RBW	100 Hz			
VBW	≥ 3 x RBW			
Span	At least 5 x Operating	Span should be large enough to include Adjacent and		
Span	Channel width	Alternate Adjacent Channel		
Detector Mode	RMS			
		Applies only for EUT generating D-M2 test signal		
Trace mode	Linear Averaging	An appropriate number of samples should be averaged to		
		give a stable reading		
	Max hold	Applies only for EUT generating D-M2a or D-M3 test signal		
NOTE: The highest and lowest operating frequencies are declared by the manufacturer.				

Step 1:

Operation of the EUT shall be started, on the Operating Frequency as declared by the manufacturer. The modulation used shall be set according to Table 2

The signal attenuation shall be adjusted to ensure that the signal power is not saturating the Spectrum analyser input port.

Step 2:

When the trace is completed, read the integrated power over a bandwidth of RBWREF centered to an offset from centre frequency as specified in Table 28. The spectrum analyser's ACP personality or an integrating marker may be used. If the spectrum analyser's ACP personality is used any additional filtering over the integrating bandwidth shall be disabled.

Table 28: Offset and RBW_{REF} parameters

Measurement	Offset from centre frequency	RBW _{REF}
Adjacent channel	±OCW	0,7 x OCW
Alternate channel	±2 x OCW	0,7 x OCW

For extreme test conditions, if the measurement is performed under normal conditions only, for EUT generating D-M1 test signal measurement can be performed with the following frequency offsets from centre frequency:

- +OCW |Negative Frequency Error| / -OCW + |Positive Frequency Error| apply for the adjacent channel
- +2xOCW |Negative Frequency Error| / -2xOCW + |Positive Frequency Error| apply for the alternate adjacent channel.

Take the higher power value from the positive and negative offsets at both the adjacent channel and alternate channel results.

Lin Averaging on the trace is an advanced SA feature. It antilogs the results averages them than takes the log again.



Measurement Record:	Uncertainty: ± 1.5dB
Test Instruments:	Refer to section 5.10 for details
Test mode:	Refer to section 5.2 for details
Test results:	N/A (Not applicable for OCW ≥ 25KHz)

7.1.10 Adaptive Power Control

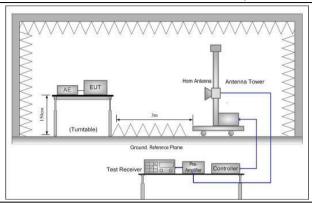
Only used in 870,000 MHz to 875,800 MHz band equipment.



7.1.11 Transmit spurious emissions

Test Requirement:	ETSI EN 300 220-2 Claus	se 4.2.2			
Test Method:	ETSI EN 300 220-1 Clause 5.9.1.2				
	Table 20: Parameters for TX Spurious Radiations Measurement				
	Operating Mode	Operating Mode Frequency Range			
	Transmit mode	9 kHz ≤ f < 150 kHz	1 kHz		
		150 kHz ≤ f < 30 MHz	10 kHz		
		30 MHz ≤ f < f _c - m	100 kHz		
		$f_c - m \le f < f_c - n$	10 kHz		
		$f_c - n \le f < f_c - p$	1 kHz		
Receiver setup:		$f_c + p < f \le f_c + n$	1 kHz		
		$f_c + n < f \le f_c + m$	10 kHz		
		f _c + m < f ≤ 1 GHz 1 GHz < f ≤ 6 GHz	100 kHz 1 MHz		
	NOTE 1: f is the measurement frequer found is the Operating Frequency m is 10 x OCW or 500 kHz, who is 4 x OCW or 100 kHz, who is 2,5 x OCW. NOTE 2: If the value of RBW used for clause 4.3.10.1.	y. whichever is the greater. whichever is the greater.	_F , use bandwidth correction from		
Test Frequency range:	25MHz to 6GHz				
Limit:	Frequency	Limit(operation)	Limit(standby)		
	47 MHz to 74 MHz				
	87.5 MHz to 118 MHz	4 347/ 54 15 3	0 14// 57 ID		
	174 MHz to 230 MHz	4nW(-54dBm)	2nW(-57dBm)		
	470 MHz to 790 MHz				
	Other frequencies	250n\M/ 26dDm\	2nM/ F7dDm)		
	below 1000 MHz	250nW(-36dBm)	2nW(-57dBm)		
	Above 1000 MHz	1uW(-30dBm)	20nW(-47dBm)		
Test setup:	Below 1GHz				
	Test Receiver	ence Plane			
	1				





Test procedure:

Substitution method was performed to determine the actual ERP emission levels of the EUT.

The following test procedure as below:

Below 1GHz:

- On the test site as test setup graph above, the EUT shall be placed at the 1.5m support on the turntable and in the position closest to normal use as declared by the provider.
- 2. The test antenna shall be oriented initially for vertical polarization and shall be chosen to correspond to the frequency of the transmitter. The output of the test antenna shall be connected to the measuring receiver.
- 3. The transmitter shall be switched on, if possible, without modulation and the measuring receiver shall be tuned to the frequency of the transmitter under test.
- 4. The test antenna shall be raised and lowered from 1m to 4m until a maximum signal level is detected by the measuring receiver. Then the turntable should be rotated through 360° in the horizontal plane, until the maximum signal level is detected by the measuring receiver.
- 5. Repeat step 4 for test frequency with the test antenna polarized horizontally.
- 6. Remove the transmitter and replace it with a substitution antenna (the antenna should be half-wavelength for each frequency involved). The center of the substitution antenna should be approximately at the same location as the center of the transmitter. At the lower frequencies, where the substitution antenna is very long, this will be impossible to achieve when the antenna is polarized vertically. In such case the lower end of the antenna should be 0.3 m above the ground.
- 7. Feed the substitution antenna at the transmitter end with a signal generator connected to the antenna by means of a nonradiating cable. With the antennas at both ends vertically polarized, and with the signal generator tuned to a particular test frequency, raise and lower the test antenna to obtain a maximum reading at the spectrum analyzer. Adjust the level of the signal generator output until the previously recorded maximum reading for this set of conditions is obtained. This should be done carefully repeating the adjustment of the test antenna and generator output.
- 8. Repeat step 7 with both antennas horizontally polarized for each test frequency.
- 9. Calculate power in dBm into a reference ideal half-wave dipole antenna

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	Report No.: G15201705000186E03
	by reducing the readings obtained in steps 7 and 8 by the power loss in the cable between the generator and the antenna, and further corrected for the gain of the substitution antenna used relative to an ideal half-wave dipole antenna by the following formula:
	ERP(dBm) = Pg(dBm) - cable loss (dB) + antenna gain (dBd)
	where:
	Pg is the generator output power into the substitution antenna.
	Above 1GHz:
	Different between above is the test site, change from Semi- Anechoic Chamber to fully Anechoic Chamber, and the test antenna do not need to raise from 1 to 4m, just test in 1.5m height.
Measurement Record:	Uncertainty: ± 6dB
Test Instruments:	Refer to section 6.0 for details
Test mode:	Refer to section 5.2 for details
Test results:	Pass

Measurement Data

Test conditions		DDW (KII-)	Frequency	Level	1.224	D!
Temprature	Voltage (AC)	RBW (KHz)	(MHz)	(dBm)	Limit	Result
25℃ 2		100	30~f _c -m	-50.77	-36dbm/100kHz	Pass
		10	fc-m~ fc-n	-61.54	-36dbm/10kHz	
	2201/	1	f _c -n∼ f _c -p	-71.35	-36dbm/1kHz	
	230V	1	f _{c+} p~ f _c +n	-74.24	-36dbm/1kHz	
		10	f _{c+} n~ f _c +m	-62.49	-36dbm/10kHz	
		100	f _{c+} m~ 1000	-50.91	-36dbm/100kHz	

Remark:

fc is 868.10MHz, OCW is 200kHz M is 10° OCW, whichever is the greater. So m is 2MHz

N is 4*OCW, whichever is the greater. So n is 0.8MHz

P is 2.5*OCW, So p is 0.5MHz

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Below 1GHz

Frequency (MHz)	Spurious Emission		Limit (dDms)	Took Doorsk
	polarization	Level(dBm)	Limit (dBm)	Test Result
366.64	Vertical	-80.33	-36.00	
440.90	V	-77.50	-36.00	
587.90	V	-73.16	-54.00	
712.21	V	-72.28	-54.00	
856.47	V	-70.18	-54.00	
970.92	V	-67.01	-36.00	1
344.35	Horizontal	-80.38	-36.00	Pass
455.79	Н	-76.94	-36.00	
532.17	Н	-74.64	-54.00	
605.51	Н	-72.29	-54.00	
786.80	Н	-70.38	-54.00	
970.92	Н	-67.03	-36.00]
		Tx in standby Mo	de	

Above 1GHz

Frequency (MHz)	Spurious	Emission	Limit (dDm)	Toot Possilt
	polarization	Level(dBm)	Limit (dBm)	Test Result
1144.00	Vertical	-56.36	-30.00	
1687.00	V	-57.02	-30.00	
2065.00	V	-57.01	-30.00	
2998.00	V	-57.28	-30.00	
3547.00	V	-55.88	-30.00	
3946.00	V	-56.23	-30.00]
1468.00	Horizontal	-57.37	-30.00	Pass
1864.00	Н	-56.93	-30.00	
2143.00	Н	-56.71	-30.00	
2494.00	Н	-56.56	-30.00	
3253.00	Н	-55.33	-30.00	
3778.00	Н	-54.85	-30.00	
	•	Tx in standby Mo	ode	•
A: Not applicable, sinc	e the spurious emi	ssion of the EUT is	too weak to be detected.(≤-70dBm)



7.1.12 TX Behaviour under Low-voltage Conditions

Test Requirement:	ETSI EN 300 220-2 Clause 4.3.8			
Test Method:	ETSI EN 300 220-1 Clause 5.12			
Receiver setup:	RBW=30Hz, VBW=100Hz, Detector= peak			
Limit:	Equipment Type Limit			
	channelized equipment	limits stated in clause 8.1.4		
		1>.within the assigned operating frequency band. And		
	non-channelized equipment	2>.the radiated or conducted power is greater than the spurious emission limits		
Test procedure:	 The carrier frequency shall be measured, where possible in the absence of modulation, with the transmitter connected to an artificial antenna. A transmitter without a 50 Ω output connector may be placed in a test fixture connected to an artificial antenna. The measurement shall be made under normal temperature and humidity conditions, Transmitter shall power by a DC power source take place the original battery power source, the voltage from the test power source shall be reduced below the lower extreme test voltage limit towards zero. Test the fundamental carrier frequency of the transmitter with nominal supply voltage Whilst the voltage is reduced the carrier frequency shall be monitored. transmitter shall be operated at the maximum rated carrier power level under normal test conditions; 			
	8. Record the woking frequen	су.		
Measurement Record:		Uncertainty: ±1 x 10 ⁻⁷		
Test Instruments:	Refer to section 6.0 for details			
Test mode:	Refer to section 5.2 for details			
Test results:	Pass			

Measurement Data:

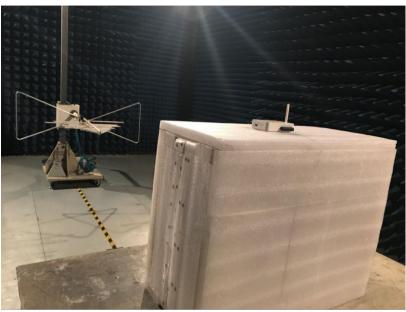
Voltage (DC)	Frequency spot (MHz)	Power (dBm)	Limit	Result
V _{normal} =230V	868.1	10.9	868.00MHz to 868.60MHz	Door
V _{extreme} =207V	868.1	9.8	000.00101112 (0 808.00101112	Pass

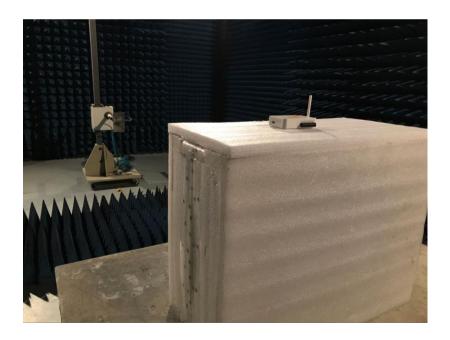
Remark:

- 1. The EUT is belong to non-channelized equipment.
- 2. V_{extreme} is the lowest operation voltage.



8 Test Setup Photo





9 EUT Constructional Details

Reference to the test report No. GTS201705000186E01

-----End-----